

LIST OF PRIOR ART CITED BY
APPLICANT

(PTO-1449)

ATTY. DOCKET NO.
P-0328APPLN. SERIAL NO.
10/036,545APPLICANT(S)
Hyo Sik SHIN, Kwang Seog BANG, and Eung
Bok KIMFILING DATE
January 7, 2002

GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
A-Z	6,181,284	01/30/2001	Madsen et al.	343	702	05/28/1999
A-Z	5,684,672	11/04/1997	Karidis et al.	361	683	02/20/1996

U.S. PATENT APPLICATION PUBLICATIONS

*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

U.S. PATENT APPLICATIONS

*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

	RECEIVED
	FEB 21 2002
	Technology Center 2600

EXAMINER

Frederick, DeLee

DATE CONSIDERED

10-14-04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

LIST OF PRIOR ART CITED BY APPLICANT

(PTO-1449)

ATTY. DOCKET NO.
P-0328

APPLN. SERIAL NO.
10/036,545

APPLICANT(S)
Hyo Sik SHIN, Kwang Seog BANG, and Eung Bok KIM

CUSTOMER NO. 34610

FILING DATE
January 7, 2002

**GROUP
2681**

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
<i>H. Z.</i>	6,100,850	08/08/2000	Utsumi	343	702	08/26/1999
<i>H. Z.</i>	5,365,246	11/15/1994	Rasinger et al.	343	702	04/27/1992

RECEIVED
MAY 05 2004

U.S. PATENT APPLICATION PUBLICATIONS

Technology Center 2600

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
1. 2	2002/0021250 A1	02/21/2002	Asano et al.	343	702	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
M. Z.	EP 0,543,645 ✓	05/26/1993	EUROPE			XX	
M. Z.	EP 0,484,454 ✓	09/28/1994	EUROPE			XX	
M. Z.	EP 1,079,296 ✓	07/24/2000	EUROPE			XX	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.